

Specificatior	n for A	pprov	val
Date: :	2019/8/3	Halven	oHS Certificate Green Partner
Customer :	聚圳臺慶	Halogen-free	Greenraturer
TAI-TECH P/N: HCB10	05KF-330T40		
CUSTOMER P/N:			
DESCRIPTION:			
QUANTITY:	pcs		
REMARK:			
Customer Ap	proval Feedback		
西北臺慶科 5		、司	
TAI-TECH Advance	d Electronics Co.,	<u>Ltd</u>	
□西北臺慶科技股份有限公司 TAI-TECH Advanced Electronics Co., Ltd <u>Headquarter:</u> NO.1 YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI,	Sales Dep.		
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TAI-TECH

High Current Ferrite Chip Bead(Lead Free)

HCB1005KF-330T40

REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAW
1.0	13/06/06	變更可靠度條件	楊祥忠	羅培君	張嘉玲
2.0	14/01/24	變更電鍍錫層厚度 3.0um min.=>3.5um min.	楊祥忠	羅培君	張嘉珠
3.0	14/03/20	修正包裝帶圖示	楊祥忠	羅培君	張嘉珠
4.0	14/08/01	變更 Reflow 圖示	楊祥忠	羅培君	張嘉玛
4.1	14/08/01	修正包裝帶尺寸	楊祥忠	羅培君	張嘉玛
5.0	16/01/26	增訂可靠度 Thermal shock: (Bead) Step3:125±2℃ 30±5min	楊祥忠	詹偉特	張嘉珠
6.0	17/02/16	修訂 Recommended PC Board Pattern	楊祥忠	詹偉特	張嘉珠
備					

TAI-TECH

High Current Ferrite Chip Bead(Lead Free)

HCB1005KF-330T40

1.Features

- 1. Monolithic inorganic material construction.
- 2. Closed magnetic circuit avoids crosstalk.
- 3. Suitable for reflow soldering.
- 4. Shapes and dimensions follow E.I.A. spec.
- 5. Available in various sizes.
- 6. Excellent solder ability and heat resistance.
- 7. High reliability.
- 8.100% Lead(Pb) & Halogen-Free and RoHS compliant.
- 9. Low DC resistance structure of electrode to prevent wasteful electric power consumption.
- 10. Operating Temperature: -55~+125 $^{\circ}$ C (Including self-temperature rise)

2.Dimensions



Chip Size						
Α	1.00±0.10					
В	0.50±0.10					
С	0.50±0.10					
D 0.25±0.10						
Units: mm						

3.Part Numbering



40=4000mA



4.Specification

F: Rated Current

Tai-Tech	Impedance (Ω)	Test Frequency	DC Resistance	Rated Current
Part Number		(Hz)	(Ω) max.	(mA) max.
HCB1005KF-330T40	33±25%	60mV/100M	0.03	4000

• Rated current: based on temperature rise test

• In compliance with EIA 595



Impedance-Frequency Characteristics



Certificate Green Partner

5. Reliability and Test Condition

Item	tem Performance						Test Condition				
Series No.	FCB	FCM	нсв	GHB		FCA					
Operating Temperature	-55~+125 $^\circ\mathrm{C}$ (Including self-temperature rise)										
Transportation Storage Temperature			-55~+125℃ (on board)				For long Applicati	-		ons, please	see the
Impedance (Z)	Refer to stan	dard electrical cl	haracteristics list				Agilent42 Agilent E Agilent42 Agilent16	4991 287			
DC Resistance							Agilent 4	338			
Rated Current							DC Powe Over Rat some ris	ted Curr		ements, the	ere will be
Temperature Rise Test		1A ΔT 20℃Max 1A ΔT 40℃Max					2. Tempe			current. by digital si	urface
Life test	Inductance: v	within±15%of init within±10%of init	ial value.				times.(If Reflow F Tempera Applied o Duration Measure for 24±2 Precond	PC/JED Profiles) ture: 12 current: : 1000± d at ro hrs. itioning:	EC J-STD 5±2°C rated curr 12hrs. om tempe Run thro	erature afte	r placing
Load Humidity		exceed the spec ±15% of initial v	cification value. /alue and shall not (exceed the spe	ecificatic	on value	times.(IPC/JEDEC J-STD-020D Classifica Reflow Profiles) Humidity: 85±2%R.H. Temperature: 85±2°C. Duration: 1000hrs Min. with 100% ra current. Measured at room temperature after pla for 24±2 hrs.			% rate	
Thermal shock	Q : Shall not	within±15%of init within±10%of init exceed the spe	ial value.	exceed the spe	ecificatio	on value	Preconditioning: Run through IR reflow for 2 times. (IPC/JEDEC J-STD-020D Classification Reflow Profiles) Condition for 1 cycle Step1: -55±2°C 30 ± 5 min. Step2: $25\pm 2°C \cong 0.5$ min Step3: +125±2°C 30 ± 5 min. Number of cycles: 500 Measured at room temperature after placing for 24±2 hrs.				
Vibration	Impedance : Inductance : Q : Shall not	: No damage. within±15% of ir within±10% of ir exceed the sper ±15% of initial v	nitial value	exceed the spe	ecificatic	on value	times.(If Reflow F Oscillation for 20 mi Equipme Total Am	PC/JED profiles) on Freq nutes ent : Vi plitude: Time : 1	EC J-STD Juency: 1 bration ch 10g 2 hours(20	ugh IR refi -020D Clas 0Hz ~ 2KH ecker 0 minutes, 1	ssification z ~ 10H:
Bending	Impedance : Inductance : Q : Shall not	: No damage. within±10% of ir within±10% of ir exceed the spec ±15% of initial v	nitial value	exceed the spe	ecificatic	on value	following >=0805in <0805in Bending >=0805in <0805in	dimens nch(201 ch(2012 depth: nch(2012 ch(2012	sions: 2mm):40x	im	
							Test co	ndition	:		
Shock	Impedance : Inductance :	: No damage. within±10% of ir within±10% of ir	nitial value				Туре	Peak Value (g's)	Normal duration (D) (ms)	Wave form	Velocity change (Vi)ft/sec
		exceed the spectrum ±15% of initial v	cification value. /alue and shall not (exceed the spe	ecificatio	on value	SMD	50	11	Half-sine	11.3
							Lead	50	11	Half-sine	11.3
Solderability	More than 95	% of the termina	I electrode should t	be covered with	n solder.		Solder te Flux for I	Sn96.5% emperati ead free omplete	5-Ag3%-C ure: 245±8 e: Rosin. 9 ly cover th	5℃	on.

Item	Performance		Те	est Con	dition
			Number of heat	cycles: 1	
Resistance to Soldering	Appearance : No damage. Impedance : within±15% of initial value		Temperature (°C)	Time (s)	Temperature ramp/immersion and emersion rate
Heat	Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not	exceed the specification value	260 ±5 (solder temp)	10 ±1	25mm/s ±6 mm/s
			Depth: complete	ely cover t	he termination
Terminal strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	radike 0,5 mm DUT wide wideness press tool when force	times.(IPC/JEE Reflow Profiles) Component mo >0805inch(2012 <=0805inch(2012 to the side of a shall be applied	DEC J-STI unted on 2mm):1kg 12mm):0.5 device be d for 60 + oplied gra	ing tested. This force 1 seconds. Also the dually as not to shock

**Derating Curve

For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over 85°C, the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



6.Soldering and Mounting

6-1. Recommended PC Board Pattern

	Chip Size							s For ering
Series	Series Type A(mm) B(mm) C(mm) D(mm)						F(mm)	G(mm)
	0603	0.6±0.03	0.30±0.03	0.30±0.03	0.15±0.05	0.35	0.30	0.40
FCB	<mark>1005</mark>	<mark>1.0±0.10</mark>	<mark>0.50±0.10</mark>	<mark>0.50±0.10</mark>	<mark>0.25±0.10</mark>	<mark>0.50</mark>	<mark>0.40</mark>	<mark>0.60</mark>
FCM	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	0.80	0.85	0.95
HCB	2012	2.0±0.20	1.25±0.20	0.85±0.20	0.50±0.30	1.05	1.00	1.45
GHB	2012	2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30	1.05	1.00	1.45
FCI	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	1.05	2.20	1.80
FHI FCH	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	1.05	2.20	2.70
нсі	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	1.05	3.30	1.80
нсі	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	1.05	3.30	3.40



ZZZ Land



PC board should be designed so that products can prevent damage from mechanical stress when warping the board.

6-2. Soldering

Mildly activated rosin fluxes are preferred. The terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools. Note.

If wave soldering is used ,there will be some risk.

Re-flow soldering temperatures below 240 degrees, there will be non-wetting risk

Upper limit

Recommendable

6-2.1 Lead Free Solder re-flow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. (Refered to J-STD-020C)

6-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. If a soldering iron must be employed the following precautions are recommended. for Iron Soldering in Figure 2.



 Use a 20 watt soldering iron with tip diameter of 1.0mm Limit soldering time to 4~5sec.





6-2.3 Solder Volume:

Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:

Minimum fillet height = soldering thickness + 25% product height

7.Packaging Information





Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	<mark>9.0±0.5</mark>	<mark>60±2</mark>	<mark>13.5±0.5</mark>	178±2
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2

7-2.1 Tape Dimension / 8mm

Material of taping is paper





Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)
060303	0.70±0.06	0.40±0.06	0.45max	2.0±0.05	0.45max
<mark>100505</mark>	<mark>1.12±0.03</mark>	<mark>0.62±0.03</mark>	<mark>0.60±0.03</mark>	<mark>2.0±0.05</mark>	<mark>0.60±0.03</mark>

Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)
160808	1.80±0.05	0.96+0.05/-0.03	0.95±0.05	4.0±0.10	0.95±0.05
201209	2.10±0.05	1.30±0.05	0.95±0.05	4.0±0.10	0.95±0.05

Material of taping is plastic



Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
201212	2.10±0.10	1.28±0.10	1.28±0.10	4.0±0.10	0.22±0.05	1.0±0.10
321611	3.35±0.10	1.75±0.10	1.25±0.10	4.0±0.10	0.23±0.05	1.0±0.10
322513	3.42±0.10	2.77±0.10	1.55±0.10	4.0±0.10	0.22±0.05	1.0±0.10
321609	3.40±0.10	1.77±0.10	1.04±0.10	4.0±0.10	0.22±0.05	1.0±0.10

7-2.2 Tape Dimension / 12mm



I	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
	451616	4.70±0.10	1.75±0.10	1.75±0.10	4.0±0.10	0.24±0.05	1.5±0.10
_	453215	4.70±0.10	3.45±0.10	1.60±0.10	8.0±0.10	0.24±0.05	1.5±0.10

7-3. Packaging Quantity

Chip Size	453215	451616	322513	321611	321609	201212	201209	160808	<mark>100505</mark>	060303
Chip / Reel	1000	2000	2500	3000	3000	2000	4000	4000	<mark>10000</mark>	15000
Inner box	4000	8000	12500	15000	15000	10000	20000	20000	<mark>50000</mark>	75000
Middle box	20000	40000	62500	75000	75000	50000	100000	100000	<mark>250000</mark>	375000
Carton	40000	80000	125000	150000	150000	100000	200000	200000	<mark>500000</mark>	750000

7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed
(°C)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

Application Notice

- Storage Conditions(component level)
 - To maintain the solder ability of terminal electrodes:
 - 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
 - 2. Temperature and humidity conditions: Less than 40 $^\circ\!\!\mathbb{C}$ and 60% RH.
 - 3. Recommended products should be used within 12 months from the time of delivery.
 - 4. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation

- 1.Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.



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號碼(No.): CE/2018/C0389 日期(Date) : 2018/12/11 頁數(Page): 1 of 15 **Test Report** 西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD. (臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.) (慶邦電子元器件(泗洪)有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.) 桃園市楊梅區幼獅工業區幼四路1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R. O. C.) (江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (中國,江蘇省,宿遷市,泗洪縣,經濟開發區杭州路南側,建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD , ECONOMIC DEVELOPMENT ZONE , SIHONG COUNTY , SUQIANCITY , JIANGSU PROVINCE , P. R , CHINA)

以下测試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

樣品名稱(Sample Description)	:	FERRITE CHIP BEAD · FERRITE CHIP INDUCTOR · ARRAY · MCF · MCM · YMV SERIES
樣品型號(Style/Item No.)	:	FERRITE CHIP BEAD · FERRITE CHIP INDUCTOR · ARRAY · MCF · MCM · YMV SERIES
收件日期(Sample Receiving Date)	:	2018/12/04
測試期間(Testing Period)	:	2018/12/04 to 2018/12/11

測試結果(Test Results) : 請參閱下一頁 (Please refer to following pages).



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日期(Date) : 2018/12/11 號碼(No.): CE/2018/C0389

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Test Report

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(中國,江蘇省,宿遷市,泗洪縣,經濟開發區杭州路南側,建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD, ECONOMIC DEVELOPMENT ZONE, SIHONG COUNTY, SUQIANCITY, JIANGSU PROVINCE, P, R, CHINA)

测试結果(Test Results)

測試部位(PART NAME)No.1 : 整體混測(MIXED ALL PARTS)

测試項目 (Test Items)	單位 (Unit)	测試方法 (Method)	方法偵測 極限值 (MDL)	結果 (Result) No.1
鐍 / Cadmium (Cd)	mg/kg	參考IEC 62321-5 (2013),以感應耦合 電漿原子發射光譜儀檢測. / With	2	n. d.
鉛 / Lead (Pb)	mg/kg	reference to IEC 62321-5 (2013) and performed by ICP-AES.	2	n. d.
汞 / Mercury (Hg)	mg/kg	參考IEC 62321-4 (2013),以感應耦合 電浆原子發射光譜儀檢測. / With reference to IEC 62321-4 (2013) and performed by ICP-AES.	2	n.d.
六價路 / Hexavalent Chromium Cr(VI)	mg/kg	参考IEC 62321-7-2 (2017),以UV-VIS 檢測. / With reference to IEC 62321-7-2 (2017) and performed by UV-VIS.	8	n. d.
六溴環十二烷及所有主要被辨別出的異構物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α - HBCDD, β - HBCDD, γ - HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	ng/kg	参考IEC 62321 (2008),以氣相層析儀 /質譜儀檢測. / With reference to IEC 62321 (2008). Analysis was performed by GC/MS.	5	n. d.

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測試項目 (Test Items)	單位 (Unit)	测試方法 (Method)	方法偵測 極限値	結果 (Result)
		<	(MDL)	No. 1
多溴聯苯總和 / Sum of PBBs	mg/kg			n. d.
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n. d.
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n. d.
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n. d.
四溴聯苯 / Tetrabromobiphenyl	ng/kg]	5	n. d.
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n. d
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n. d.
七溴聯苯 / Heptabromobiphenyl	mg/kg		5	n. d.
へ溴聯苯 / Octabromobiphenyl	mg/kg		5	n. d.
九溴聯苯 / Nonabromobiphenyl	mg/kg	参考IEC 62321-6 (2015),以氣相層析	5	n. d.
十溴聯苯 / Decabromobiphenyl	mg/kg	儀/質譜儀檢測. / With reference to	5	n. d
多溴聯苯醚總和 / Sum of PBDEs	mg/kg	IEC 62321-6 (2015) and performed	_	n, d.
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg	by GC/MS.	5	n. d.
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg] [5	n. d.
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg] [5	n. d.
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg] [5	n. d.
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n. d.
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg] [5	n.d.
七溴聯苯醚 / Heptabromodiphenyl ether	ng∕kg]	5	n. d.
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg] [5	n. d.
九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg	1 [5	n. d.
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg	1	5	n. d.

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Test Report

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.)

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桃園市楊梅區幼獅工業區幼四路1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R. O. C.)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA)

(中國,江蘇省,宿遷市,泗洪縣,經濟開發區杭州路南側,建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST IIANSHE ROAD , ECONOMIC DEVELOPMENT ZONE , SIHONG COUNTY , SUQIANCITY , JIANGSU PROVINCE , P. R , CHINA)

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鄰苯二甲酸丁苯甲酯 / BBP (Butyl Benzyl phthalate) (CAS No.: 85-68-7)	ng/kg		50	n. d.
鄰苯二甲酸二丁酯 / DBP(Dibuty1 phthalate)(CAS No.: 84-74-2)	mg/kg		50	n. d.
鄰苯二甲酸二 (2-乙基己基)酯 / DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	mg/kg		50	n. d.
鄰苯二甲酸二異丁酯 / DIBP (Di- isobutyl phthalate) (CAS No.: 84-69- 5)	mg/kg	參考IEC 62321-8 (2017),以氣相層析	50	n. d.
鄰苯二甲酸二異癸酯 / DIDP (Di- isodecyl phthalate) (CAS No.: 26761- 40-0; 68515-49-1)	mg/kg	儀/質譜儀檢測. / With reference to IEC 62321-8 (2017). Analysis was performed by GC/MS.	50	n. d.
鄰苯二甲酸二異壬酯 / DINP (Di- isononyl phthalate) (CAS No.: 28553- 12-0; 68515-48-0)	mg/kg		50	n. d.
鄰苯二甲酸二正辛酯 / DNOP (Di-n- octyl phthalate) (CAS No.: 117-84-0)	mg/kg		50	n. d.
鄰苯二甲酸二正己酯 / DNHP (Di-n- hexyl phthalate) (CAS No.: 84-75-3)	mg/kg]	50	n. d.
鄰苯二甲酸二戊酯 / DNPP (Di-n-pentyl phthalate) (CAS No.: 131-18-0)	mg/kg		50	n. d.

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Test Report

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測試項目 (Test Items)	單位 (Unit)	测試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鹵素 / Halogen				
鹵素 (氟) / Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg		50	n. d.
鹵素(氯)/ Halogen-Chlorine (Cl) (CAS No.: 22537-15-1)	mg/kg	参考BS EN 14582 (2016),以離子層析 儀分析. / With reference to BS EN 14582 (2016). Analysis was performed by IC.	50	n.d.
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg		50	n. d.
鹵素 (碘) / Halogen-Iodine (I) (CAS No.: 14362-44-8)	mg/kg		50	n, d.
全氟辛烷磺酸 / Perfluorooctane sulfonates (PFOS-Acid, Metal Salt, Amide)	mg/kg	參考US EPA 3550C (2007),以液相層 析儀/質譜儀檢測. / With reference to US EPA 3550C (2007). Analysis	10	n. d.
全氟辛酸 / PFOA (CAS No.: 335-67-1)	mg/kg	was performed by LC/MS.	10	n. d.
聚氯乙烯 / PVC	**	以紅外光譜分析及焰色法檢測. / Analysis was performed by FTIR and FLAME Test.	-	Negative
銻 / Antimony (Sb)	mg/kg	參考US EPA 3052 (1996),以感應耦合 電浆原子發射光譜儀檢測. / With reference to US EPA 3052 (1996).	2	n. d.
种 / Arsenic (As)	mg/kg		2	n. d.
鉞 / Beryllium (Be)	mg/kg	Analysis was performed by ICP-AES.	2	n. d.

SGS Talovan Ltd 台湾検強科技役份有常公司 25, Wu Chyuan 7th Road, New Taipei Industrial Park, Wu Ku District, New Taipei City, Taiwan 御北市五殿福新北產業園區五曜七路25號



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備註(Note):

- 1. mg/kg = ppm; 0.1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限值)
- 4. "-" = Not Regulated (無規格值)
- 5. **= Qualitative analysis (No Unit) 定性分析(無單位)
- 6. Negative = Undetectable 陰性(未偵測到); Positive = Detectable 陽性(已偵測到)
- 7. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量. (The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

PFOS濃度在物質或製備中不得超過0.001%(10ppm),在半成品、成品或零部件中不得超過0.1%(1000ppm),在紡織品或塗層材料中不得超過1µg/m²。

(Outlawing PFOS as substances or preparations in concentrations above 0.001% (10ppm), in semi-finished products or articles or parts at a level above 0.1%(1000ppm), in textiles or other coated materials above $1\mu g/m^2$.)

8. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量. (The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

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Test Report

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重金屬流程圖 / Analytical flow chart of Heavy Metal

根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外) These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr6+ test method excluded)

测试人員:陳恩臻 / Technician: Rita Chen



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多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBB/PBDE

- 測試人員:凃雅苓 / Technician: Yaling Tu
- 測試負責人: 張啟興 / Supervisor: Troy Chang



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<u>可塑劑分析流程圖 / Analytical flow chart - Phthalate</u>

- 測試人員:凃雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang

【测試方法/Test method: IEC 62321-8】



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六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD

- 測試人員:凃雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang



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鹵素分析流程圖 / Analytical flow chart - Halogen

- 測試人員:陳恩臻 / Technician: Rita Chen
- 測試負責人:張啟興 / Supervisor: Troy Chang



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號碼(No.) : CE/2018/C0389 日期(Date) : 2018/12/11

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Test Report

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.)

(慶邦電子元器件(泗洪)有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.)

桃園市楊梅區幼獅工業區幼四路1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R. O. C.)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA)

(中國,江蘇省,宿遷市,泗洪縣,經濟開發區杭州路南側,建設北路東側 / THE SOUTH HANGZHOU ROAD AND THE EAST JIANSHE ROAD, ECONOMIC DEVELOPMENT ZONE, SIHONG COUNTY, SUQIANCITY, JIANGSU PROVINCE, P, R, CHINA)

全氟辛酸/全氟辛烷磺酸分析流程圖 / Analytical flow chart - PFOA/PFOS

- 測試人員: 涂雅苓 / Technician: Yaling Tu
- 测試負責人:張啟興 / Supervisor: Troy Chang



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聚氯乙烯物質判定分析流程圖 / Analysis flow chart - PVC

- 測試人員:凃雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang



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根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.

- 測試人員: 陳恩臻 / Technician: Rita Chen
- 測試負責人:張啟興 / Supervisor: Troy Chang

元素以 ICP-AES 分析的消化流程圖

(Flow Chart of digestion for the elements analysis performed by ICP-AES)



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* 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. * (The tested sample / part is marked by an arrow if it's shown on the photo.)



** 報告結尾 (End of Report) **

ANOTHER SIDE

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